# imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

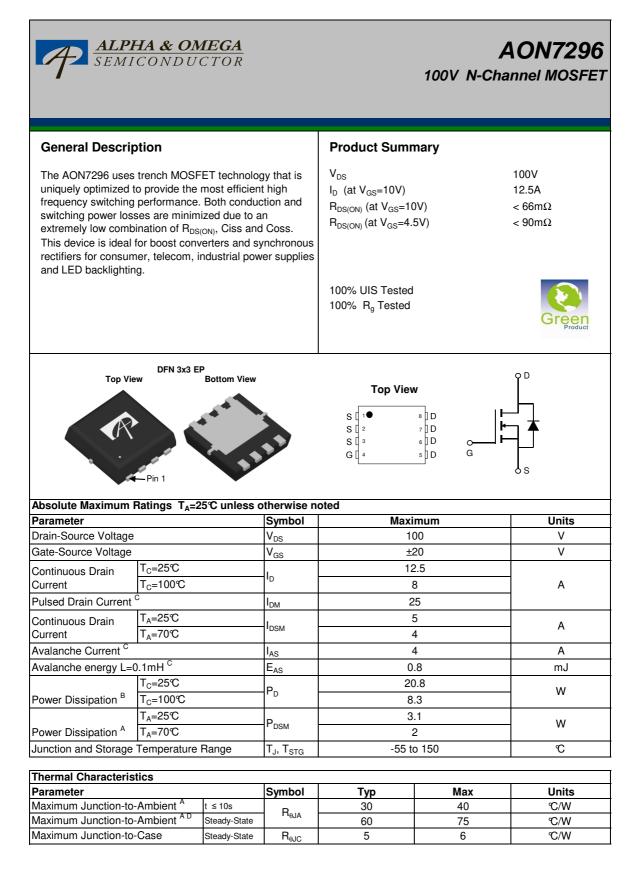
We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



# Contact us

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#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		100			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V				1	
			T_=55℃			5	μA
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 20V$				±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$		1.7	2.3	2.8	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V		25			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_{D}$ =5A			54	66	<b>m</b> 0
			T <sub>J</sub> =125℃		100	122	mΩ
		$V_{GS}$ =4.5V, $I_{D}$ =3A			72	90	mΩ
<b>g</b> fs	Forward Transconductance	$V_{DS}$ =5V, $I_{D}$ =5A			13.5		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.76	1	V
ls	Maximum Body-Diode Continuous Cu	rrent <sup>G</sup>			16	Α	
DYNAMIC	C PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz			415		pF
C <sub>oss</sub>	Output Capacitance				32		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				3		pF
R <sub>g</sub>	Gate resistance	$V_{GS}=0V, V_{DS}=0V, f=1MHz$		0.7	1.4	2.1	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =5A			6.5	12	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge				3	6	nC
Q <sub>gs</sub>	Gate Source Charge				1.5		nC
Q <sub>gd</sub>	Gate Drain Charge				1.5		nC
t <sub>D(on)</sub>	Turn-On DelayTime	$V_{GS}$ =10V, $V_{DS}$ =50V, $R_{L}$ =10 $\Omega$ , $R_{GEN}$ =3 $\Omega$			4		ns
t <sub>r</sub>	Turn-On Rise Time				2		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				15		ns
t <sub>f</sub>	Turn-Off Fall Time				2		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =5A, dl/dt=500A/μs			16		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =5A, dI/dt=500A/μs			44		nC

A. The value of R<sub>6JA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation  $P_{DSM}$  is based on R <sub>eJA</sub> t  $\leq$  10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial  $T_{J} = 25^{\circ}$  C.

D. The  $R_{\text{BJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{BJC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

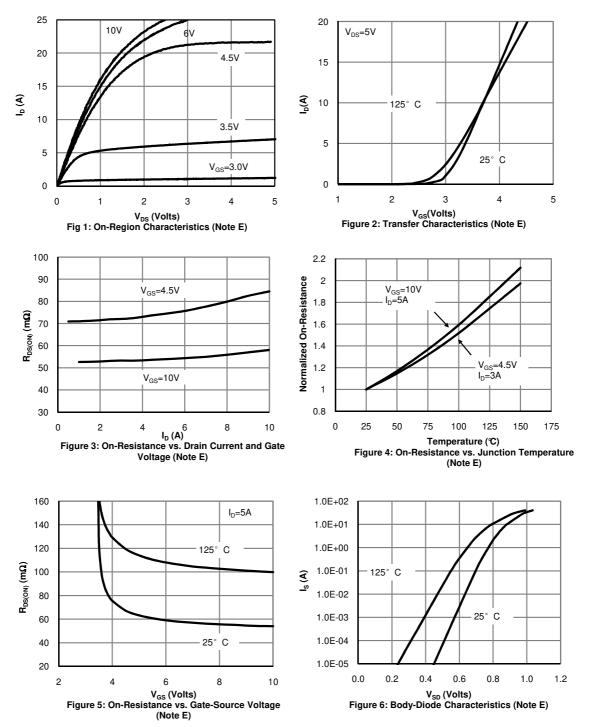
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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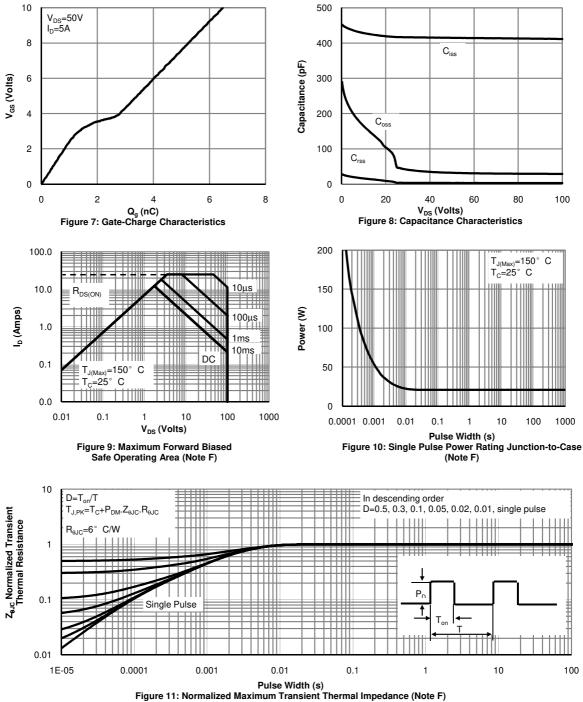


## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





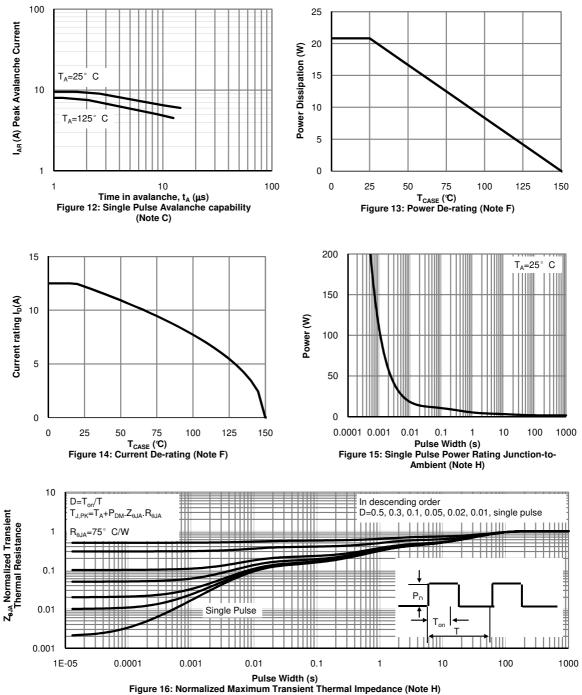
# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





ALPHA & OMEGA

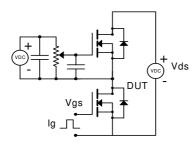
SEMICONDUCTOR

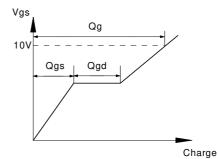




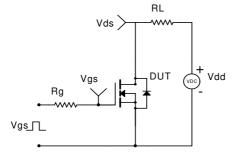


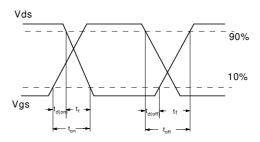
#### Gate Charge Test Circuit & Waveform



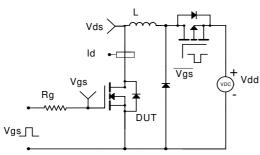


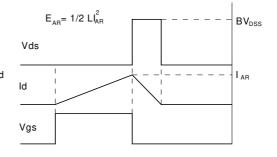
# Resistive Switching Test Circuit & Waveforms





## Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





#### Diode Recovery Test Circuit & Waveforms

